Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/535,171	FUKUI ET AL.	
Examiner	Art Unit	
Huyen Le	3751	

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Class	Subclass	Date	Examiner
401	107109	9/17/2007	HL
	updated		
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
US-PGPUB		9/17/2007	HL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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